## Abstract Submitted for the MAR14 Meeting of The American Physical Society

Domain Structures and Anisotropy  $\mathbf{in}$ Exchange-coupled [Co/Pd]-NiFe and [Co/Ni]-NiFe Multilayers LARYSA TRYPUTEN, MIT, SUNJAE CHUNG, MAJID MOHSENI, T.N. ANH NGUYEN, JOHAN ÅKERMAN, KTH Royal Institute of Technology, FENG GUO, ROBERT D. MCMICHAEL, NIST, CAROLINE A. ROSS, MIT — Exchange-coupled multilayers  $[Co/Pd]_5$ -/NiFe and  $[Co/Ni]_4$ -NiFe with strong perpendicular magnetic anisotropy have been proposed to use in spin-torque switching and oscillators devices with tilted fixed and free layer to improve their functional performance. We present an experimental study of the magnetization behavior of [Co/Pd]<sub>5</sub>-/NiFe and [Co/Ni]<sub>4</sub>-NiFe multilayers measured using magnetometry, magnetic force microscopy (MFM) and ferromagnetic resonance (FMR) as a function of the thickness of the top NiFe layer. We varied the thickness of the NiFe layer in  $[Co/Pd]_5$ -NiFe (t), t = 0 - 80 nm and  $[Co/Ni]_4$ -NiFe (t), t = 0.5 - 2.5 nm in order to study the interplay between perpendicular magnetization of the Co/Pd or Co/Ni multilayers and in-plane magnetization of the NiFe. Our magnetometry and FMR data suggest that the  $[Co/Ni]_4/NiFe$ multilayer behaves like a homogeneous ferromagnetic film with anisotropy that reorients towards in-plane as the NiFe thickness increases, whereas the  $[Co/Pd]_5/NiFe$ multilayer reveals more complex behavior in which the [Co/Pd] layer retains out-ofplane anisotropy while the magnetization of NiFe layer tilts in-plane with increasing thickness. MFM showed that domains with  $\sim 0.1 \pm m$  size were visible in [Co/Pd]-/NiFe with NiFe thickness of 20-80 nm. Multilayers were patterned into sub-100 nm dots using ion beam etching and their magnetization behavior are compared with unpatterned films.

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